Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/537,061	PASTAN ET AL.	
Examiner	Art Unit	
David J. Blanchard	1643	

David J. Blanchard

SEARCHED						
Class	Subclass	Date	Examiner			
	- ·					

INT	INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner			
			:			
SEQ ID Nos:3, 7, 8		2/7/2007	DB			

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
WEST, STN, inventor search (see search history printout)	2/7/2007	DB	
STIC search SEQ ID Nos:3, 7, 8 (results in SCORE)	1/9/2007	· DB	
Inventor search in PALM	2/7/2007	DB .	
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